Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination	
10528845	HOSHINO ET AL.	
Examiner	Art Unit	
IQBAL H CHOWDHURY	1652	

	SEARCHED		
Class	Subclass	Date	Examine

SEARCH NOTES	
Date	Examiner
5/12/2009	IC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
STIC search	sequence search of SEQ ID NO: 1 and 2 against patent and pending databases	5/12/2009	IC

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